BUK95/962R8-30B

TrenchMOS™ logic level FET Rev. 02 — 14 October 2002

Product data

Product profile

1.1 Description

N-channel enhancement mode field-effect power transistor in a plastic package using Philips High-Performance Automotive TrenchMOS™ technology.

Product availability:

BUK952R8-30B in SOT78 (TO-220AB) BUK962R8-30B in SOT404 (D2-PAK).

1.2 Features

- Very low on-state resistance
- 175 °C rated

- Q101 compliant
- Logic level compatible.

1.3 Applications

- Automotive systems
- Motors, lamps and solenoids
- 12 V loads
- General purpose power switching.

1.4 Quick reference data

- $E_{DS(AL)S} \le 2.3 J$
- $I_D \le 75 A$

- \blacksquare R_{DSon} = 2.4 mΩ (typ)
- $P_{tot} \le 300 \text{ W}.$

Pinning information 2.

Table 1: Pinning - SOT78 and SOT404 simplified outlines and symbol

Pin	Description	Simplified outline	Symbol	
1	gate (g)	mb	mb	
2	drain (d)	[1]	d	
3	source (s)			
mb	mounting base, connected to drain (d)	MBK106	g MBB076 S	
		SOT78 (TO-220AB)	SOT404 (D ² -PAK)	

[1] It is not possible to make connection to pin 2 of the SOT404 package.





3. Limiting values

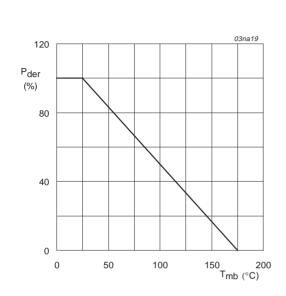
Table 2: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)		-	30	V
V_{DGR}	drain-gate voltage (DC)	$R_{GS} = 20 \text{ k}\Omega$	-	30	V
V_{GS}	gate-source voltage (DC)		-	±15	V
I _D	drain current (DC)	$T_{mb} = 25 ^{\circ}C; V_{GS} = 5 V;$	[1] _	237	Α
		Figure 2 and 3	[2]	75	Α
		$T_{mb} = 100 ^{\circ}\text{C}; V_{GS} = 5 \text{V}; \text{Figure 2}$	[2]	75	Α
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$; Figure 3	-	950	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; Figure 1	-	300	W
T _{stg}	storage temperature		-55	+175	°C
Tj	junction temperature		-55	+175	°C
Source-	drain diode				
I _{DR}	reverse drain current (DC)	T _{mb} = 25 °C	[1] _	237	Α
			[2]	75	Α
I _{DRM}	peak reverse drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \mu s$	-	950	Α
Avalanci	ne ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	unclamped inductive load; I _D = 75 A; $V_{DS} \le 30$ V; $V_{GS} = 5$ V; $R_{GS} = 50$ Ω ; starting $T_{mb} = 25$ °C	-	2.3	J

^[1] Current is limited by power dissipation chip rating

^[2] Continuous current is limited by package



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature.

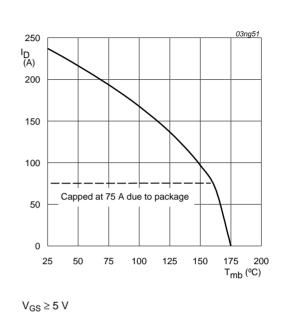
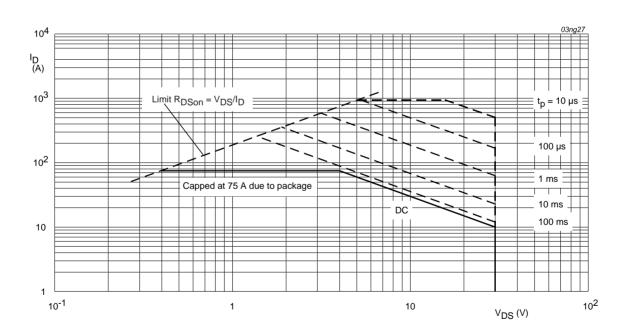


Fig 2. Continuous drain current as a function of mounting base temperature.



 T_{mb} = 25 °C; I_{DM} single pulse.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

4. Thermal characteristics

Table 3: Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Figure 4	-	-	0.5	K/W	
$R_{th(j-a)}$	thermal resistance from junction to ambient						
	SOT78	vertical in still air	-	60	-	K/W	
	SOT404	mounted on a printed circuit board; minimum footprint	-	50	-	K/W	

4.1 Transient thermal impedance

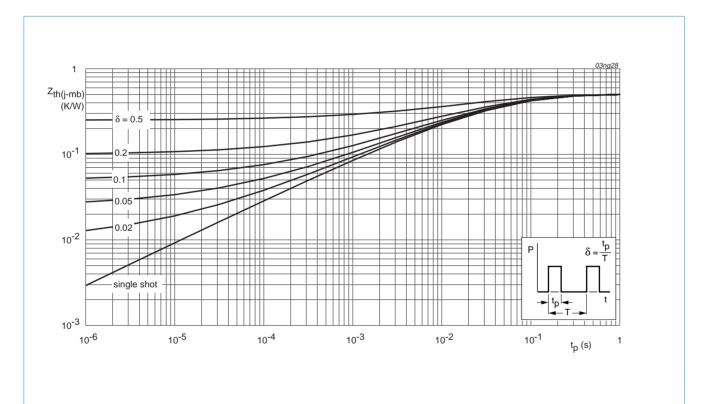


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration.

5. Characteristics

Table 4: Characteristics

 $T_i = 25 \,^{\circ}C$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}$				
	voltage	T _j = 25 °C	30	-	-	V
		T _j = −55 °C	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS};$ Figure 9				
		T _j = 25 °C	1.1	1.5	2	V
		T _j = 175 °C	0.5	-	-	V
		T _j = −55 °C	-	-	2.3	V
I _{DSS}	drain-source leakage current	V _{DS} = 30 V; V _{GS} = 0 V				
		T _j = 25 °C	-	0.02	1	μΑ
		T _j = 175 °C	-	-	500	μΑ
I _{GSS}	gate-source leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0 \text{ V}$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A};$ Figure 7 and 8				
		T _i = 25 °C	-	2.4	2.8	mΩ
		T _i = 175 °C	-	-	5.3	mΩ
		V _{GS} = 4.5 V; I _D = 25 A	-	-	3.0	mΩ
		V _{GS} = 10 V; I _D = 25 A	-	2.0	2.4	mΩ
Dynamic (characteristics					
Q _{g(tot)}	total gate charge	$V_{GS} = 5 \text{ V}; V_{DD} = 24 \text{ V};$ $I_D = 25 \text{ A}; Figure 14$	-	89	-	nC
Q _{gs}	gate-to-source charge		-	22	-	nC
Q_{gd}	gate-to-drain (Miller) charge		-	35	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V;	-	7640	10185	pF
C _{oss}	output capacitance	f = 1 MHz; Figure 12	-	1600	1920	pF
C _{rss}	reverse transfer capacitance		-	735	1006	pF
t _{d(on)}	turn-on delay time	$V_{DD} = 30 \text{ V}; R_L = 1.2 \Omega;$	-	71	-	ns
t _r	rise time	$V_{GS} = 5 \text{ V}; R_G = 10 \Omega$	-	222	-	ns
t _{d(off)}	turn-off delay time		-	260	-	ns
t _f	fall time		-	195	-	ns
L _d	internal drain inductance	from drain lead 6 mm from package to centre of die	-	4.5	-	nΗ
		from contact screw on mounting base to centre of die SOT78	-	3.5	-	nΗ
		from upper edge of drain mounting base to centre of die SOT404	-	2.5	-	nH
L _s	internal source inductance	from source lead to source bond pad	-	7.5	-	nΗ

 Table 4:
 Characteristics...continued

 $T_i = 25 \,^{\circ}C$ unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit			
Source-di	Source-drain diode								
V_{SD}	source-drain (diode forward) voltage	$I_S = 40 \text{ A}; V_{GS} = 0 \text{ V};$ Figure 15	-	0.85	1.2	V			
t _{rr}	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}$	-	109	-	ns			
Q _r	recovered charge	$V_{GS} = -10 \text{ V}; V_{DS} = 20 \text{ V}$	-	171	-	nC			

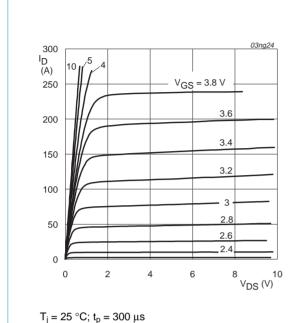
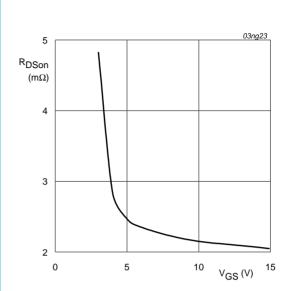


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



 $T_i = 25 \,^{\circ}C; I_D = 25 \,^{\circ}A$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values.

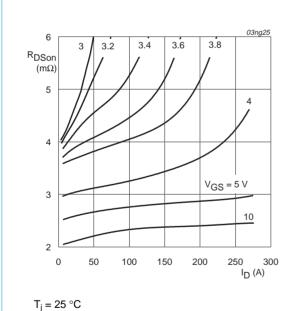
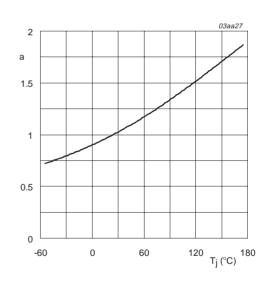


Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.

 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

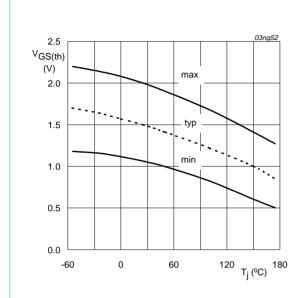
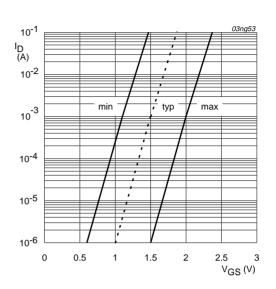


Fig 9. Gate-source threshold voltage as a function of junction temperature.



 $T_i = 25 \,^{\circ}C; V_{DS} = V_{GS}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.

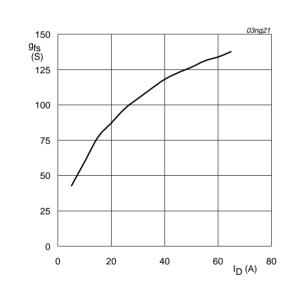
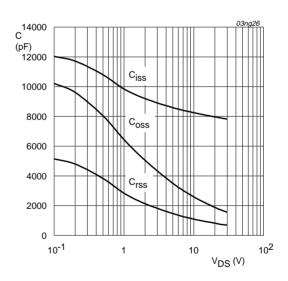


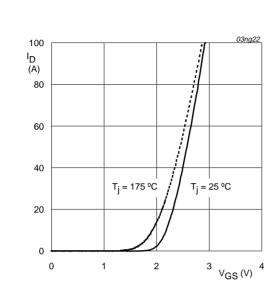
Fig 11. Forward transconductance as a function of drain current; typical values.

 $T_j = 25 \,^{\circ}C; \, V_{DS} = 25 \,^{\circ}V$



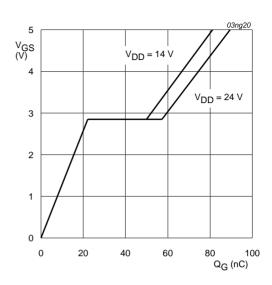
 $V_{GS} = 0 V; f = 1 MHz$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



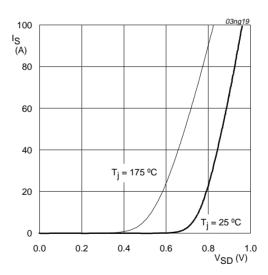
 $V_{DS} = 25 \text{ V}$

Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



 $T_i = 25 \,^{\circ}C; I_D = 25 \,^{\circ}A$

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values.



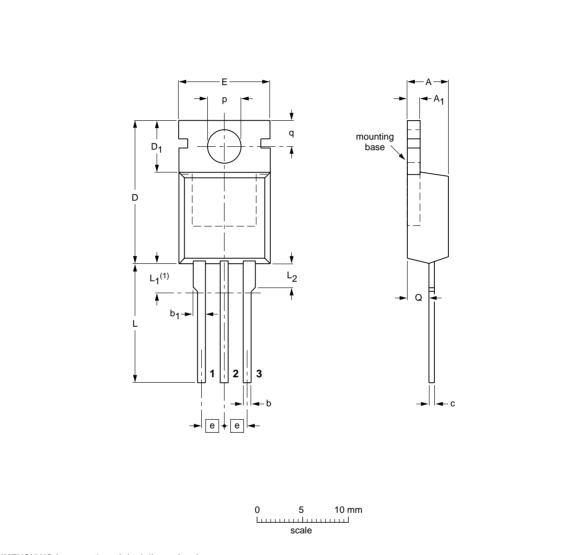
 $V_{GS} = 0 V$

Fig 15. Reverse diode current as a function of reverse diode voltage; typical values.

6. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78



DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	b ₁	С	D	D ₁	E	е	L	L ₁ ⁽¹⁾	L ₂ max.	р	q	Q
mm	4.5 4.1	1.39 1.27	0.9 0.7	1.3 1.0	0.7 0.4	15.8 15.2	6.4 5.9	10.3 9.7	2.54	15.0 13.5	3.30 2.79	3.0	3.8 3.6	3.0 2.7	2.6 2.2

Note

1. Terminals in this zone are not tinned.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT78		3-lead TO-220AB	SC-46		00-09-07 01-02-16

Fig 16. SOT78 (TO-220AB).

Plastic single-ended surface mounted package (Philips version of D²-PAK); 3 leads (one lead cropped)

SOT404

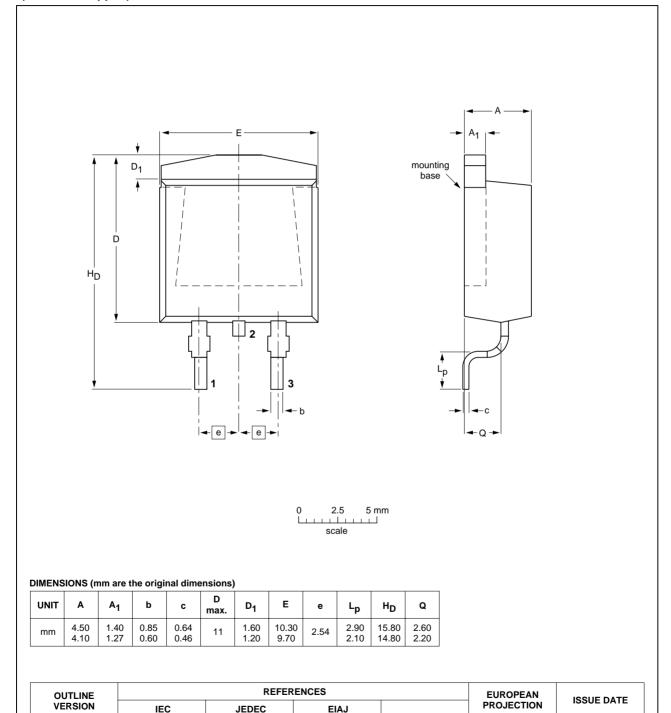


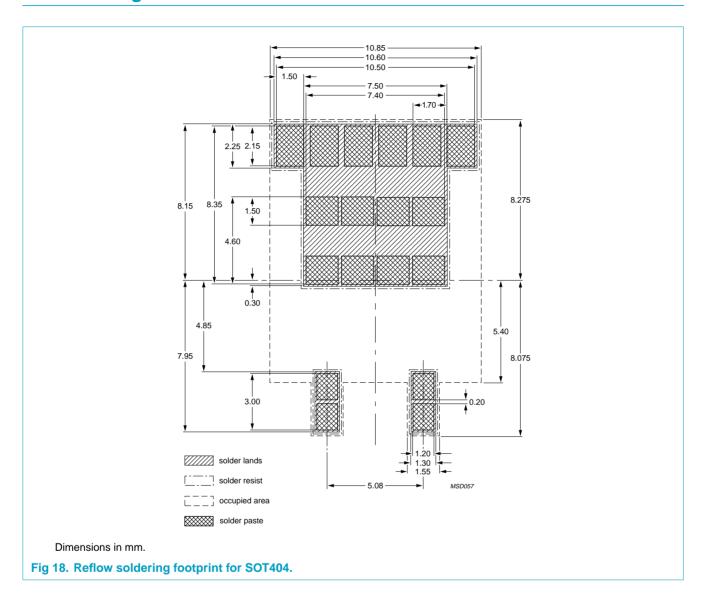
Fig 17. SOT404 (D2-PAK)

SOT404

99-06-25

01-02-12

7. Soldering



8. Revision history

Table 5: Revision history

Rev	Date	CPCN	Description
02	20021014	-	Product data (9397 750 10273)
			Modification:
			 Description in Section 1 changed from:
			N-channel enhancement mode field-effect power transistor in a plastic package using generation three TrenchMOS [™] technology, featuring very low on-state resistance. to:
			N-channel enhancement mode field-effect power transistor in a plastic package using Philips High-Performance Automotive TrenchMOS™ technology.
01	20020326	-	Product data (9397 750 09488)

9. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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- [2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.
- [3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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